Probes FD13H / FDW13H / D-FN Data Sheet

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Probe models	FD13H	FDW	13H	D-FN	
Part no. ¹	604-508	604-	-800	1006632	
Measurement tasks	Coating thickness on steel or iron	base material (FE)	; NC/FE or NF/FE	<u>I</u>	
	Coating thickness on non-ferrous r	netal base materia	al (NF); NC/NF		
Applications	Probes for measurements on virtually all metals. The probes work with two test methods and are therefore able to measure coating thicknesses on non-ferrous metals (NF) as well as on ferrous metals (FE). Because of the large pole tip the probes are also well suited for measurements on rough (blasted) surfaces.				
Examples	Steel or iron base material (FE)		Non-ferrous meta	al base materials (NF)	
	 Paint, varnish, rubber or plastic coatings on steel, iron or cast iron (NC/FE) 		Paint, varnish or plastic coatings on aluminium, copper or brass (NC/NF)		
	 Copper, brass, zinc, tin and chrome coatings on steel or iron (NF/FE) 				
	 Both electro-galvanized and hot gal on steel, iron or cast iron (NF/FE) 	vanized coatings			
Features	 Preferably for measurements on flat surfaces Excellently suited for measurements on rough surfaces, measurements on smooth surfaces are of course also possible Wear-resistant probe pole tip 				
	 Probe model FD13H also available as digital probe (D-FN), in which the measurement signal is already converted into the measured value directly in the probe 				
	■ Probe D-FN: Humidity protection				
	-	Non-ferrous metal base materials (NF)			
			■ The probes measure with a high-precision conductivity compensation developed by Helmut Fischer, so different electrical conductivities of the base material (particularly various aluminium alloys) have no effect on the coating thickness measurement.		
Restrictions			Strong influence due to surface curvatures		
Measuring ranges*	Steel or iron base material (FE)		Non-ferrous metal base materials (NF)		
	0 2000 μm (0 78.74 mils)		0 2000 µm (0 78.74 mils)		
	The values for measurement range, true precision and measurement deviations trically non-conductive coating material (NC/FE). The values may differ for meas ferrous coating materials (NF).	are valid for elec- 's on steel or iron	-		
	The specifications for trueness) and repeatability precision apply to ambient and specimen temperatures at the time of calibration. The values for trueness and repeatability may increase compared to the values specified here if the temperature during measurement differs from the temperature during calibration.				
Trueness*	Steel or iron base material (FE)		Non-ferrous meta	al base materials (NF)	
based on Fischer factory calibration standards at 20 °C (68 °F) for specimen and ambient temperature	0 75 μ m: ≤ 1.5 μ m 75 1000 μ m: ≤ 2 % of nominal value 1000 2000 μ m: ≤ 3 % of nominal value		0 50 μm: ≤ 1 μm 50 1000 μm: ≤ 2 % of nominal value 1000 2000 μm: ≤ 3 % of nominal value		
	(0 2.95 mils: \leq 0.06 mils) (2.95 39.37 mils: \leq 2 % of nominal value) (39.37 78.74 mils: \leq 3 % of nominal value)		(0 1.97 mils: ≤ 0.039 mils) (1.97 39.37 mils: ≤ 2 % of nominal value) (39.37 78.74 mils: ≤ 3 % of nominal value)		

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Probes FD13H / FDW13H / D-FN

Repeatability precision*

based on Fischer factory calibration standards at 20 $^{\circ}\text{C}$ (68 $^{\circ}\text{F})$ for specimen and ambient temperature

Steel or iron base material (FE)

0 ... 50 μ m: $\leq 0.25 \mu$ m 50 ... 2000 μ m: $\leq 0.5 \%$ of reading (0 ... 1.97 mils: ≤ 0.0098 mils) (1.97 ... 78.74 mils: $\leq 0.5 \%$ of reading)

Non-ferrous metal base materials (NF)

0 ... 100 μ m: \leq 0.5 μ m 100 ... 2000 μ m: \leq 0.5 % of reading (0 ... 3.94 mils: \leq 0.02 mils) (3.94 ... 78.74 mils: \leq 0.5 % of reading)

Influence*

Steel or iron base material (FE)

Non-ferrous metal base materials (NF)

The following values are valid for a coating thickness with a nominal value of 75 µm (2.95 mils).

The quantity of influences are stated with the expanded measurement uncertainty U with the expanded factor of k = 2 (defines an interval with the confidence level of 95.45 %) – according to ISO/IEC Guide 98-3:2008-09 "Guide to the expression of uncertainty in measurement".

Curvature (R), measurement deviation from nominal value with reference to a calibration on flat surface

Measuring spot



No influence within the scope of trueness from R = 55 mm \pm 9 mm (R = 2.17 " \pm 0.35 ") Measurement deviation of 10 % for R = 28 mm \pm 1.6 mm (R = 1.10 " \pm 0.063 ")

No influence within the scope of trueness from R = 550 mm \pm 56 mm (R = 21.65 " \pm 2.2 ") Measurement deviation of 10 % for R = 110 mm \pm 5.6 mm (R = 4.33 " \pm 0.22 ")

FD13H and FDW13H probes require a minimum of R = 25 mm (support stand necessary) (R = 0.98 ") D-FN probe requires a minimum of R = 29 mm (support stand necessary) (R = 1.14 ")

Curvature (R), measurement deviation from nominal value with reference to a calibration on flat surface

Measuring spot



No influence within the scope of trueness from R = 80 mm \pm 5 mm (R = 3.14 " \pm 0.2 ") Measurement deviation of 10 % for R = 16 mm \pm 1.2 mm (R = 0.63 " \pm 0.047 ")

No influence within the scope of trueness from R = 447 mm \pm 28 mm (R = 17.6 " \pm 1.1 ") Measurement deviation of 10 % for R = 92 mm \pm 3.4 mm (R = 3.62 " \pm 0.13 ")

FD13H and D-FN probes needs a minimum of R = 1.5 mm (support stand necessary) (R = 0.06 ") FDW13H probe needs a minimum of R = 2 mm (support stand necessary) (R = 0.08 ")

Edge distance (R), specification from probe tip center, measurement deviation from nominal value

Measuring spot in the center of the R circular surface



No influence within the scope of trueness from R = 11.5 mm \pm 0.3 mm (R = 0.45 " \pm 0.012 ") Measurement deviation of 10 % for R = 6.4 mm \pm 0.3 mm (R = 0.25 " \pm 0.012 ")

No influence within the scope of trueness from R = $3.2 \text{ mm} \pm 0.2 \text{ mm}$ (R = $0.13 \text{ "} \pm 0.0079 \text{ "}$) Measurement deviation of 10 % for R = $2.4 \text{ mm} \pm 0.04 \text{ mm}$ (R = $0.094 \text{ "} \pm 0.0016 \text{ "}$)

FD13H and FDW13H probes require a minimum of R = 7 mm (support stand necessary) (R = 0.28 ") D-FN probe requires a minimum of R = 8 mm (support stand necessary) (R = 0.32 ")

Edge distance (X), specification from probe tip center, measurement deviation from nominal value

Measuring spot = Probe pole center



No influence within the scope of trueness from X = 3.6 mm \pm 0.3 mm (X = 0.14 " \pm 0.012 ") Measurement deviation of 10 % for X = 1.0 mm \pm 0.05 mm (X = 0.039 " \pm 0.002 ")

No measurement deviation within the trueness - for FD13H and D-FN probe as of

 $X = 2.2 \text{ mm} \pm 0.05 \text{ mm} (X = 0.087 \text{ "} \pm 0.002 \text{ "})$

- for FDW13H probe as of X = 2.2 mm \pm 0.1 mm (X = 0.087 " \pm 0.004 ")

Measurement deviation of 10 % for $X = 1.9 \text{ mm} \pm 0.04 \text{ mm}$ (X = 0.075 " \pm 0.0016 ")

Base material thickness (D), measurement deviation from nominal value

Measuring spot -



Steel or iron base material (FE)

No influence within the scope of trueness from D = 1.0 mm \pm 0.1 mm (D = 39.4 mils \pm 3.94 mils) Measurement deviation of 10 % for D = 0.5 mm \pm 0.03 mm (D = 19.7 mils \pm 1.18 mils)

Base material Aluminium

No influence within the scope of trueness from D = 0.1 mm \pm 0.01 mm (D = 3.94 mils \pm 0.39 mils) Measurement deviation of 10 % for D = 0.02 mm \pm 0.001 mm (D = 0.79 mils \pm 0.039 mils)

Base material

Steel or iron base material (FE)

Influence on base material (FE) permeability in regard to Fischer calibration standards (master calibration): No measurement error for a ferrite content from 137 FN \pm 0.2 FN onwards. Measurement error of 10 % for ferrite content of 123 FN \pm 0.8 FN.

Non-ferrous metal base materials (NF)

Influence of the el. conductivity of the base material (NF) in the range from 30 to 100 % IACS: Measurement deviation \leq 2 %, valid for the total measurement range.

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Probes FD13H / FDW13H / D-FN

Probe design Dimensions Approach and touchdown speed for automated measurement FD13H probe 90 mm v ≥ 10 mm/s Single pole axial probes with (3.54) $(v \ge 0.39 \text{ "/s})$ spring-loaded measuring system 24 mm Area for holding or **Ø** 9 mm (0.35 ") Probe pole tip (0.95 " v ≤ 4 mm/s 2 mm clamping the probe wear-resistant Ø 14 mm (0.55 ") (0.079 $(v \le 0.16 \text{ "/s})$ material: hard metal Range of spring: 1.4 mm (0.055 ") Specimen radius: 2 mm (0.079 ") not replaceable Probe cable length: 1.5 m (59.06 "), other cable lengths on request 1 Lift-off distance between 2 measure-Bending radius: ≥ 30 mm (1.18 ") ments $\geq 8 \text{ mm} \ (\geq 0.32 \text{ "})$ FDW13H probe 81 mm (3.12 ") v > 10 mm/sSingle pole angle probe with $(v \ge 0.39 \text{ "/s})$ spring-loaded measuring 26 mm (1.02 ") system 12 mm Probe pole tip 20 mm v < 4 mm/s 2 mm mm (0.59 ") 14 mm wear-resistant (v < 0.16 "/s)(0.079)(0.73)18.5 5 (0.5")material: hard metal Ø Area (24 mm / 0.95 ") for hold-Ø Specimen radius: 2 mm (0.079 ") ing or clamping the probe Range of spring: 1 mm (0.04") not replaceable Probe cable length: 1.5 m (59.06 "), other cable lengths on request 1 Lift-off distance between 2 measure-Bending radius: ≥ 30 mm (1.18 ") ments ≥ 8 mm (≥ 0.32 ") D-FN probe Illumination 70 mm (2.76 ") v ≥ 10 mm/s Ø 14 mm ring Single pole axial probes $(v \ge 0.39 \text{ "/s})$ (0.5")with spring-loaded measuring system Humidity protection USB screw $v \le 4 \text{ mm/s}$ **ø** 17 mm 2 mm Ø 9 mm (0.35 ") port, type C $(v \le 0.16 \text{ "/s})$ (0.079 ") Probe pole tip (0.67)Ø 16 mm (0.63 ") wear-resistant 15 mm Specimen Range of spring: 1.4 mm (0.055 ") material: hard metal (0.59)Area for holding or clamping the probe radius: 2 mm (0.079 ") not replaceable Probe cable length: 1.5 m (59.06 "), other cable lengths on request 1 Lift-off distance between 2 measure-Bending radius: ≥ 30 mm (1.18 ") ments $\geq 8 \text{ mm} \ (\geq 0.32 \text{ "})$ Non-ferrous metal base materials (NF) Measuring methods Steel or iron base material (FE) Magnetic induction test method according to ISO 2178, Amplitude-sensitive eddy current test method accord-**ASTM D7091** ing to ISO 2360, ASTM D7091 Calibration - Calibration foils Steel or iron base material (FE) Non-ferrous metal base materials (NF) 1-Point calibration The 1-Point-Calibration is practicably in the lower measuring range only. This calibration method provides the best measuring accuracy in a small coating thickness range close by the stated foil thickness. Use following foil thickness for max. 1000 μm (39.37 mils) The calibration using two calibration foils provides on the one hand the best measuring accuracy in the coating thick-2-Point calibration ness range limited by the two foil thicknesses and on the other hand two calibration foils are necessary for calibrating the upper measurement range. Use following foil thickness pair-Foil 1: ≤ 300 µm (11.8 mils); Foil 2: ≥ 800 µm (31.5 mils) | Foil 1: ≤ 600 µm (23.6 mils); Foil 2: ≥ 1000 µm (39.37 mils) ings for calibration -10 °C ... +40 °C (+14 °F ... +104 °F) Admissible ambient temperature at operation max. +40 °C (+104 °F) Admissible specimen temperature

Probes FD13H / FDW13H / D-FN

Probes work with				
FD13H and FDW13H (analog probes)	 Hand-held instruments: all DUALSCOPE[®] instruments of the FMP series FD13H: all DUALSCOPE[®] instruments of the DMP series by using DMP-F-Probe-Adapter (1007336) Bench top instruments: FISCHERSCOPE[®] MMS[®] PC and FISCHERSCOPE[®] MMS[®] PC2 both with PERMASCOPE[®] F-Probe module (604-293, 12-pin connecting socket) 			
D-FN (digital probe)	■ Hand-held instruments: all DUALSCOPE® instruments of the DMP series			
Scope of delivery	• All: Probe with connecting cable, calibration foil sets 605-413 (metal plate NF/FE for instrument check, 2 calibration foils with thicknesses of approx. 9 μm (0.35 mils) (CuBe) and 125 μm (4.92 mils)) and 605-415 (metal plate NC/NF for instrument check, 2 calibration foils with thicknesses of approx. 24 μm (0.95 mils) and 250 μm (9.84 mils))			
	 FD13H, additional: prism adapter for measurements on pipes and bars 			
	■ D-FN: probe connecting cable with screwable USB C plugs			
Options	 Calibration foils: various foil thickness are available up to 1500 µm (59.06 mils); suitable calibration foil thicknesses are specified in section Calibration – Calibration foils Manufacturer Certificate M according to DIN 55350-18 (only in connection with measuring instrument) Support stand V12 BASE, 604-420, with mechanical probe lowering device; FD13H: suitable probe clamp 602-370 included in support stand delivery D-FN: suitable probe clamp 600-213 FDW13H: no probe clamp available Support stand V12 MOT, 604-374, with motorized probe lowering device for highest repeatability; FD13H: suitable probe clamp 602-370 included in support stand delivery D-FN: suitable probe clamp 600-213 FDW13H: no probe clamp available 			

Probes with special cable lengths have own part no. and probe model names. This data sheet also applies to these probes. Probe D-FN: max. cable length 3 m (118 °), it not allowed to use a USB connection cable to connect probe to instrument!

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